



HEXFET® Power MOSFET

Application

- Brushed Motor drive applications
- BLDC Motor drive applications
- PWM Inverterized topologies
- Battery powered circuits
- Half-bridge and full-bridge topologies
- Electronic ballast applications
- Synchronous rectifier applications
- Resonant mode power supplies
- OR-ing and redundant power switches
- DC/DC and AC/DC converters

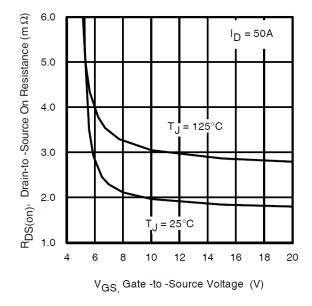
| V _{DSS} | 40V |
|--------------------------|-------|
| R _{DS(on)} typ. | 1.8mΩ |
| max | 2.4mΩ |
| I _D | 159A |

Benefits

- Improved Gate, Avalanche and Dynamic dV/dt Ruggedness
- Fully Characterized Capacitance and Avalanche SOA
- Enhanced body diode dV/dt and dI/dt Capability
- RoHS Compliant containing no Lead, no Bromide, and no Halogen



| Doos part number | Dookogo Tyroo | Standard Pack | | Orderable Bart Number | Note |
|------------------|----------------|---------------|----------|-----------------------|------------------|
| Base part number | Раскаде туре | Form | Quantity | Orderable Part Number | Note |
| IRFH7440PbF | PQFN 5mm x 6mm | Tape and Reel | 4000 | IRFH7440TRPbF | |
| | PQFN 5mm x 6mm | Tape and Reel | 400 | IRFH7440TR2PbF | EOL notice # 259 |





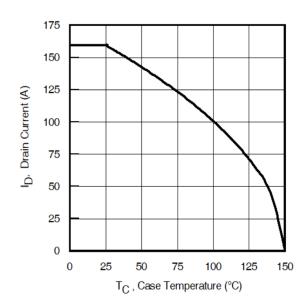


Fig 2. Maximum Drain Current vs. Case Temperature



Absolute Maximum Rating

| Symbol | Parameter | Max. | Units |
|---|---|--------------|-------|
| I _D @ T _{C(Bottom)} = 25°C | Continuous Drain Current, V _{GS} @ 10V ① | 159 | |
| I _D @ T _{C(Bottom)} = 100°C | Continuous Drain Current, V _{GS} @ 10V ① | 101 | Α |
| I _{DM} | Pulsed Drain Current ② | 636 | |
| P _D @ T _C = 25°C | Maximum Power Dissipation | 104 | W |
| | Linear Derating Factor | 0.83 | W/°C |
| V_{GS} | Gate-to-Source Voltage | ± 20 | V |
| dv/dt | Peak Diode Recovery® | 3.0 | V/ns |
| T _J T _{STG} | Operating Junction and Storage Temperature Range | -55 to + 150 | °C |

Avalanche Characteristics

| Symbol | Parameter | Max. | Units |
|-------------------------------------|---------------------------------|--------------------------|-------|
| E _{AS} (Thermally limited) | Single Pulse Avalanche Energy ③ | 121 | m l |
| E _{AS} (Thermally limited) | Single Pulse Avalanche Energy ® | 232 | mJ |
| I _{AR} | Avalanche Current ② | Soc Fig 15, 16, 22c, 22h | Α |
| E _{AR} | Repetitive Avalanche Energy ② | See Fig 15, 16, 22a, 22b | mJ |

Thermal Resistance

| | Parameter | Тур. | Max. | Units |
|---------------------------|-----------------------|------|------|-------|
| R _{θJC} (Bottom) | Junction-to-Case | | 1.2 | |
| R ₀ JC (Top) | Junction-to-Case ® | | 31 | °C/W |
| $R_{	hetaJA}$ | Junction-to-Ambient ® | | 35 | C/VV |
| R _{θJA} (<10s) | Junction-to-Ambient ® | | 22 | |

Static @ T_J = 25°C (unless otherwise specified)

| Symbol | Parameter | Min. | Тур. | Max. | Units | Conditions |
|---------------------------------|--------------------------------------|------|-------|------|-------|---|
| $V_{(BR)DSS}$ | Drain-to-Source Breakdown Voltage | 40 | | | V | $V_{GS} = 0V, I_D = 250\mu A$ |
| $\Delta V_{(BR)DSS}/\Delta T_J$ | Breakdown Voltage Temp. Coefficient | | 0.031 | | mV/°C | Reference to 25°C, I _D = 1.0mA |
| В | Static Drain-to-Source On-Resistance | | 1.8 | 2.4 | mΩ | $V_{GS} = 10V, I_D = 50A$ |
| $R_{DS(on)}$ | Static Diam-to-Source On-Resistance | | 2.7 | | | $V_{GS} = 6.0V, I_D = 25A$ |
| $V_{GS(th)}$ | Gate Threshold Voltage | 2.2 | | 3.9 | V | $V_{DS} = V_{GS}$, $I_D = 100\mu A$ |
| I _{DSS} | Drain-to-Source Leakage Current | | | 1.0 | | $V_{DS} = 40V$, $V_{GS} = 0V$ |
| | | | | 150 | μA | $V_{DS} = 40V, V_{GS} = 0V, T_{J} = 125^{\circ}C$ |
| I _{GSS} | Gate-to-Source Forward Leakage | | | 100 | nΛ | $V_{GS} = 20V$ |
| | Gate-to-Source Reverse Leakage | | | -100 | nA | $V_{GS} = -20V$ |
| R_G | Gate Resistance | | 2.6 | | Ω | |

Notes:

- ① Rating refers to the product only with datasheet specified absolute maximum values, maintaining case temperature at 25°C. For higher case temperature please refer to Diagram 2. De-rating will be required based on the actual environmental conditions.
- ② Repetitive rating; pulse width limited by max. junction temperature.
- \odot Limited by T_{Jmax}, starting T_J = 25°C, L = 0.097mH, R_G = 50 Ω , I_{AS} = 50A, V_{GS} = 10V.

- © Coss eff. (TR) is a fixed capacitance that gives the same charging time as Coss while VDS is rising from 0 to 80% VDSS.
- \odot C_{oss} eff. (ER) is a fixed capacitance that gives the same energy as C_{oss} while V_{DS} is rising from 0 to 80% V_{DSS}.
- When mounted on 1 inch square 2 oz copper pad on 1.5 x 1.5 in. board of FR-4 material.
- \mathfrak{G} R_θ is measured at T_J approximately 90°C.
- \odot Limited by T_{Jmax}, starting T_J = 25°C, L = 1mH, R_G = 50 Ω , I_{AS} = 22A, V_{GS} =10V.



Dynamic Electrical Characteristics @ $T_J = 25^{\circ}C$ (unless otherwise specified)

| Symbol | Parameter | Min. | Тур. | Max. | Units | Conditions |
|--------------------|---|------|------|------|-------|--|
| gfs | Forward Transconductance | 149 | | | S | V _{DS} = 10V, I _D = 50A |
| Q_g | Total Gate Charge | | 92 | 138 | | I _D = 50A |
| Q_{gs} | Gate-to-Source Charge | | 22 | | | $V_{DS} = 20V$ |
| Q_{gd} | Gate-to-Drain Charge | | 29 | | nC | V _{GS} = 10V ⑤ |
| Q _{sync} | Total Gate Charge Sync. (Qg - Qgd) | | 63 | | | |
| t _{d(on)} | Turn-On Delay Time | | 12 | | | $V_{DD} = 20V$ |
| t _r | Rise Time | | 45 | | | I _D = 30A |
| $t_{d(off)}$ | Turn-Off Delay Time | | 53 | | ns | $R_G = 2.7\Omega$ |
| t _f | Fall Time | | 42 | | | V _{GS} = 10V ⑤ |
| C _{iss} | Input Capacitance | | 4574 | | | $V_{GS} = 0V$ |
| C _{oss} | Output Capacitance | | 700 | | | $V_{DS} = 25V$ |
| C _{rss} | Reverse Transfer Capacitance | | 466 | | pF | f = 1.0 MHz |
| Coss eff.(ER) | Effective Output Capacitance (Energy Related) | | 863 | | | V _{GS} = 0V, V _{DS} = 0V to 32V⊘ |
| Coss eff.(TR) | Output Capacitance (Time Related) | | 1229 | | | $V_{GS} = 0V, V_{DS} = 0V \text{ to } 32V$ (6) |

Diode Characteristics

| Symbol | Parameter | Min. | Тур. | Max. | Units | Conditions |
|------------------|--|------|----------|------|-------|---|
| Is | Continuous Source Current (Body Diode) | | | 80 | | MOSFET symbol showing the |
| I _{SM} | Pulsed Source Current (Body Diode) ② | | | 636 | 1 | integral reverse p-n junction diode. |
| V_{SD} | Diode Forward Voltage | | 0.9 | 1.3 | V | $T_J = 25^{\circ}C, I_S = 50A, V_{GS} = 0V $ |
| t _{rr} | Reverse Recovery Time | | 25 27 | | ns | $T_J = 25^{\circ}C$ $V_{DD} = 34V$ $T_J = 125^{\circ}C$ $I_F = 50A$, |
| Q _{rr} | Reverse Recovery Charge | | 16 17 | | nC | <u>T_J = 25°C</u> di/dt = 100A/μs ⑤ <u>T_J = 125°C</u> |
| I _{RRM} | Reverse Recovery Current | | 1.2 | | Α | T _J = 25°C |



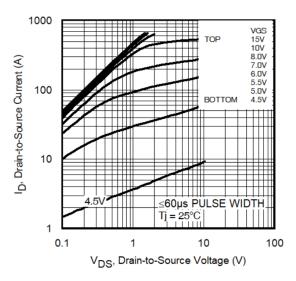


Fig 3. Typical Output Characteristics

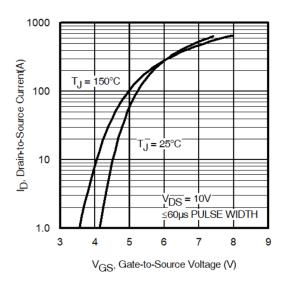


Fig 5. Typical Transfer Characteristics

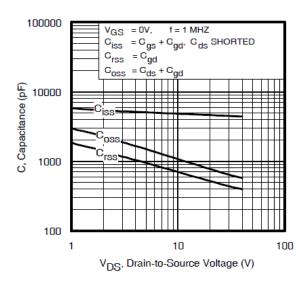


Fig 4. Typical Output Characteristics

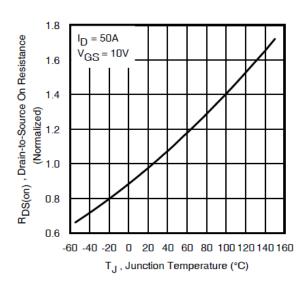


Fig 6. Normalized On-Resistance vs. Temperature

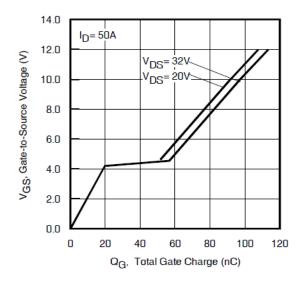


Fig 7. Typical Capacitance vs. Drain-to-Source Voltage

Fig 8. Typical Gate Charge vs. Gate-to-Source Voltage

4



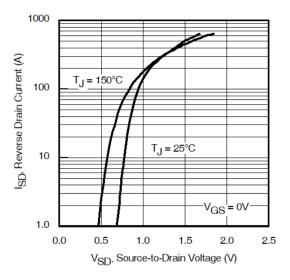


Fig 9. Typical Source-Drain Diode Forward Voltage

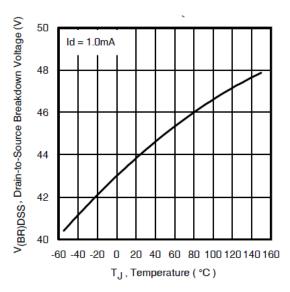


Fig 11. Drain-to-Source Breakdown Voltage

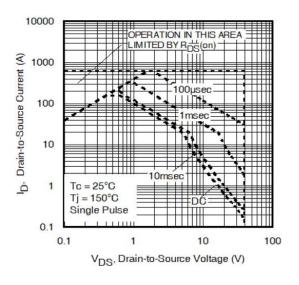


Fig 10. Maximum Safe Operating Area

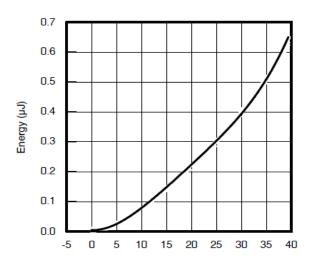


Fig 12. Typical Coss Stored Energy

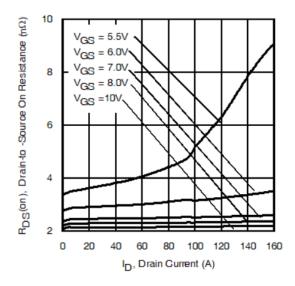


Fig 13. Typical On-Resistance vs. Drain Current

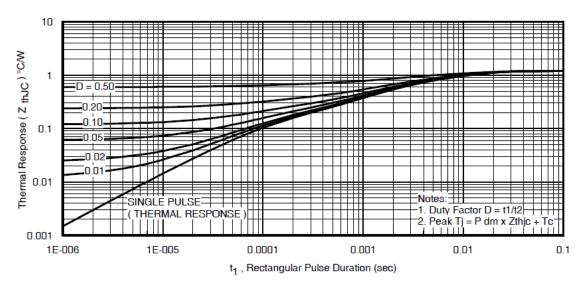


Fig 14. Maximum Effective Transient Thermal Impedance, Junction-to-Case

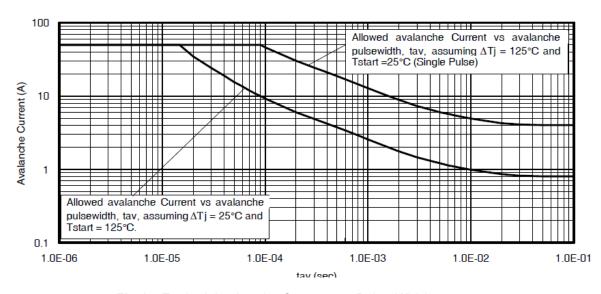


Fig 15. Typical Avalanche Current vs. Pulse Width

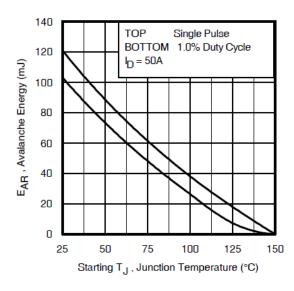


Fig 16. Maximum Avalanche Energy vs. Temperature

Notes on Repetitive Avalanche Curves, Figures 15, 16: (For further info, see AN-1005 at www.irf.com)

- 1. Avalanche failures assumption: Purely a thermal phenomenon and failure occurs at a temperature far in excess of T_{jmax}. This is validated for every part type.
- 2. Safe operation in Avalanche is allowed as long asT_{jmax} is not exceeded.
- 3. Equation below based on circuit and waveforms shown in Figures 22a, 22b.
- 4. $P_{D (ave)}$ = Average power dissipation per single avalanche pulse.
- 5. BV = Rated breakdown voltage (1.3 factor accounts for voltage increase during avalanche).
- 6. I_{av} = Allowable avalanche current.
- 7. ΔT = Allowable rise in junction temperature, not to exceed T_{imax} (assumed as 25°C in Figure 14, 16). t_{av} = Average time in avalanche.

D = Duty cycle in avalanche = tav ·f

 $Z_{thJC}(D, t_{av})$ = Transient thermal resistance, see Figures 13) PD (ave) = 1/2 ($1.3 \cdot BV \cdot I_{av}$) = $\Delta T/Z_{thJC}$

 $I_{av} = 2\Delta T / [1.3 \cdot BV \cdot Z_{th}]$ $E_{AS (AR)} = P_{D (ave)} t_{av}$



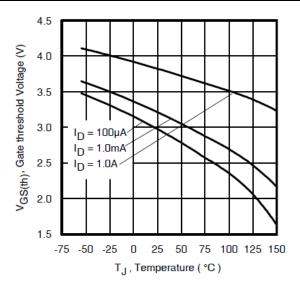


Fig 17. Threshold Voltage vs. Temperature

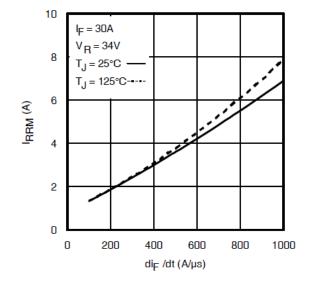


Fig 18. Typical Recovery Current vs. dif/dt

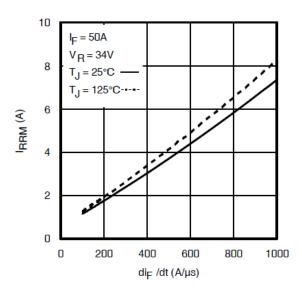


Fig 19. Typical Recovery Current vs. dif/dt

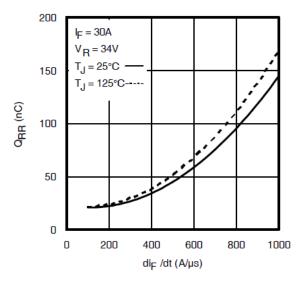


Fig 20. Typical Stored Charge vs. dif/dt

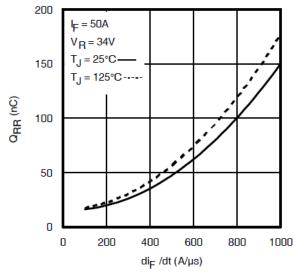


Fig 21. Typical Stored Charge vs. dif/dt



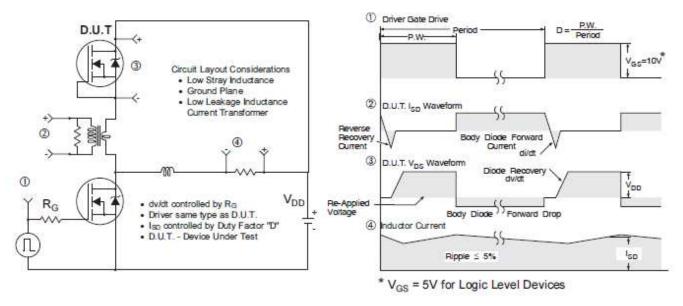


Fig 22. Peak Diode Recovery dv/dt Test Circuit for N-Channel HEXFET® Power MOSFETs

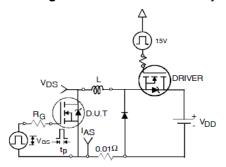


Fig 23a. Unclamped Inductive Test Circuit

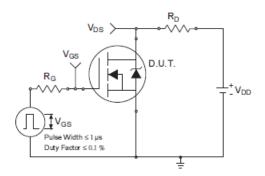


Fig 24a. Switching Time Test Circuit

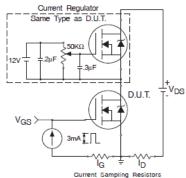


Fig 25a. Gate Charge Test Circuit

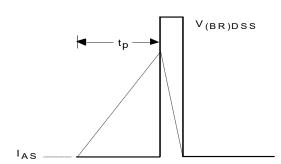


Fig 23b. Unclamped Inductive Waveforms

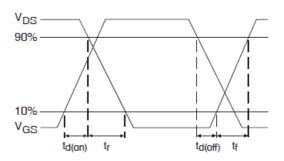


Fig 24b. Switching Time Waveforms

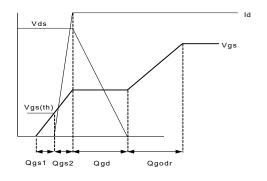
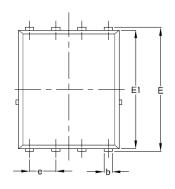


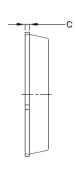
Fig 25b. Gate Charge Waveform

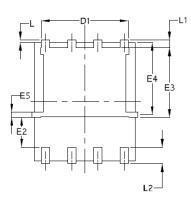
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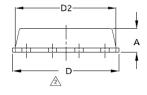


PQFN 5x6 Outline "E" Package Details



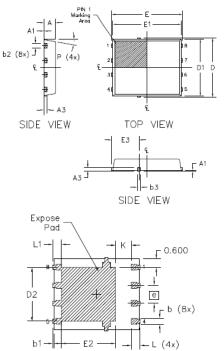






| S Y | COMMON | | | | | | |
|--------|--------|-------|--------|--------|--|--|--|
| M B | IV | 1M | INCH | | | | |
| O L | MIN. | MAX. | MIN. | MAX. | | | |
| Α | 0.90 | 1.17 | 0.0354 | 0.0461 | | | |
| b | 0.33 | 0.48 | 0.0130 | 0.0189 | | | |
| C | 0.195 | 0.300 | 0.0077 | 0.0118 | | | |
| D | 4.80 | 5.15 | 0.1890 | 0.2028 | | | |
| D1 | 3.91 | 4.31 | 0.1539 | 0.1697 | | | |
| D2 | 4.80 | 5.00 | 0.1890 | 0.1968 | | | |
| Е | 5.90 | 6.15 | 0.2323 | 0.2421 | | | |
| E1 | 5.65 | 6.00 | 0.2224 | 0.2362 | | | |
| E2 | 1.51 | | 0.0594 | _ | | | |
| E3 | 3.32 | 3.78 | 0.1307 | 0.1480 | | | |
| E4 | 3.42 | 3.58 | 0.1346 | 0.1409 | | | |
| E5 | 0.18 | 0.32 | 0.0071 | 0.0126 | | | |
| е | 1.27 | BSC | 0.050 | BSC | | | |
| L | 0.05 | 0.25 | 0.0020 | 0.0098 | | | |
| L1 | 0.38 | 0.66 | 0.0150 | 0.0260 | | | |
| L2 | 0.51 | 0.86 | 0.0201 | 0.0339 | | | |
| | 0 | 0.18 | 0 | 0.0071 | | | |

PQFN 5x6 Outline "G" Package Details



BOTTOM VIEW

| DIM | MILLIMETERS | | | NCH | | |
|--------|-------------|------------------|-------------|--------|-------|-----|
| SYMBOL | MIN. | MAX. | MIN. | MAX. | | |
| Α | 0.950 | 1.050 | 0.0374 | 0.0413 | | |
| A1 | 0.000 | 0.050 | 0,0000 | 0.0020 | | |
| А3 | 0.254 | REF | 0.0100 | REF | | |
| Ь | 0.310 | 0.510 | 0.0122 | 0.0201 | | |
| b1 | 0.025 | 0.125 | 0.0010 | 0.0049 | | |
| b2 | 0.210 | 0.410 | 0.0083 | 0.0161 | | |
| b3 | 0.180 | 0.450 | 0.0071 | 0.0177 | | |
| D | 5.150 | BSC | 0.2028 | BSC | | |
| D1 | 5.000 | 00 BSC 0.1969 BS | | BSC | | |
| D2 | 3.700 | 3.900 | 0.1457 | 0.1535 | | |
| Е | 6.150 | BSC | 0.2421 BSC | | | |
| E1 | 6.000 | BSC | 0.2362 | BSC | | |
| E2 | 3.560 | 3.760 | 0.1402 | 0.1488 | | |
| E3 | 2.270 | 2.470 | 0.0894 | 0.0972 | | |
| е | 1.27 REF | | 1.27 REF 0. | | 0.050 | REF |
| K | 0.830 | 1.400 | 0.0327 | 0.0551 | | |
| L | 0.510 | 0.710 | 0.0201 | 0.0280 | | |
| L1 | 0.510 | 0.710 | 0.0201 | 0.0280 | | |
| Р | 10 deg | 12 deg | 0 deg | 12 deg | | |

Note:

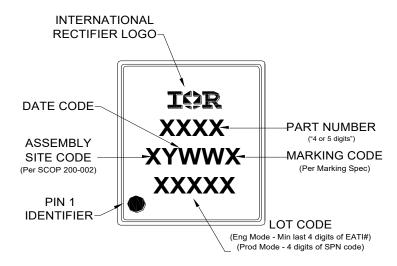
- Dimensions and toleranceing confirm to ASME Y14,5M-1994
- Dimension L represents terminal full back from package edge up to 0,1mm is acceptable
- Coplanarity applies to the expose Heat Slug as well as the terminal
- 4. Radius on terminal is Optional

For more information on board mounting, including footprint and stencil recommendation, please refer to application note AN-1136: http://www.irf.com/technical-info/appnotes/an-1136.pdf

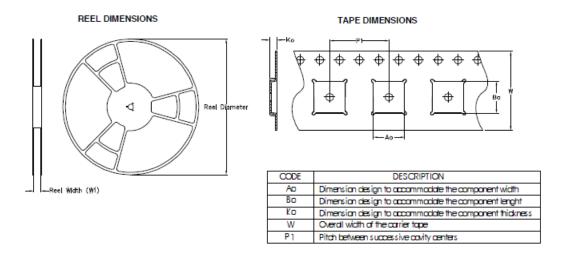
For more information on package inspection techniques, please refer to application note AN-1154: Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



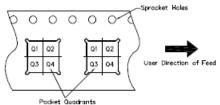
PQFN 5x6 Part Marking



PQFN 5x6 Tape and Reel



QUADRANT ASSIGNMENTS FOR PIN 1 ORIENTATION IN TAPE



Nate: All almension are nominal

| Paakage Type | Reel Diameter (Inch) | ØTY | Reel Wiath W1 (mm) | Aa (mm) | Bo (mm) | (mm) | P1 (mm) | W (mm) | Pin 1 Quadrant |
|-----------------|----------------------------|------|-----------------------------|------------|------------|------|------------|-----------|-------------------|
| 5X6PQFN | 13 | 4000 | 12.4 | 6.300 | 5.300 | 1.20 | 8.00 | 12 | ଭା |

Note: For the most current drawing please refer to IR website at http://www.irf.com/package/



Qualification Information

| Qualification level | Industrial (per JEDEC JESD47F [†] guidelines) | | | | |
|----------------------------|---|---|--|--|--|
| Moisture Sensitivity Level | PQFN 5mm x 6mm | MSL1 (per JEDEC J-STD-020D ^{†)} | | | |
| RoHS Compliant | Yes | | | | |

[†] Applicable version of JEDEC standard at the time of product release.

Revision History

| Date | Rev | Comments |
|------------|-----|---|
| 01/13/2014 | 2.1 | Updated ordering information to reflect the End-Of-Life (EOL) of the mini-reel option (EOL notice #259). Updated data sheet with the new IR corporate template. |
| 02/19/2015 | 2.2 | Updated EAS (L =1mH) = 232mJ on page 2 Updated note 10 "Limited by TJmax, starting T_J = 25°C, L = 1mH, R_G = 50Ω, I_{AS} = 22A, V_{GS} =10V". on page 2 |
| 06/2/2015 | 2.3 | Updated package outline for "option E" and added package outline for "option G" on page 9. Updated "IFX" logo on page 1 & 11. Updated tape and reel on page 10. |
| 07/07/2015 | 2.4 | Corrected package outline for "option E" on page 9. |
| 04/16/2020 | 2.5 | Updated datasheet based on IFX template. Updated Datasheet based on new current rating and application note :App-AN_1912_PL51_2001_180356 |



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Edition 2016-04-19 Published by Infineon Technologies AG 81726 Munich, Germany

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